TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII.5)

2SK1544

DC-DC Converter and Motor Drive Applications

Unit: mm

 $\begin{array}{ll} \bullet & \text{Low drain-source ON resistance} & : \text{RDS (ON)} = 0.15 \ \Omega \ \text{(typ.)} \\ \bullet & \text{High forward transfer admittance} & : | \text{Y}_{fs}| = 21 \ \text{S (typ.)} \\ \bullet & \text{Low leakage current} & : \text{IDSS} = 300 \ \mu\text{A (max)} \ \text{(V}_{DS} = 500 \ \text{V)} \\ \end{array}$

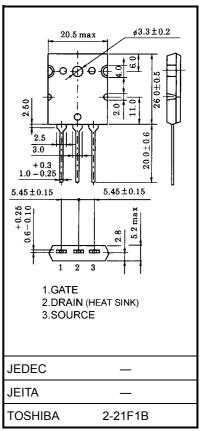
• Enhancement-mode : $V_{th} = 1.5 \sim 3.5 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	500	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	500	V	
Gate-source voltage		V_{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	25	Α	
	Pulse (Note 1)	I_{DP}	100	A	
Drain power dissipation (Tc = 25°C)		P_{D}	200	W	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.625	°C / W
Thermal resistance, channel to ambient	R _{th (ch-a)}	35.7	°C/W



Weight: 9.75 g (typ.)

Note 1: Please use devices on condition that the channel temperature is below 150°C.

This transistor is an electrostatic sensitive device.

Please handle with caution.

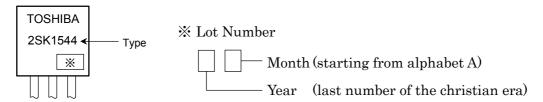
Electrical Characteristics (Ta = 25°C)

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±25 V, V _{DS} = 0 V	-	_	±100	nA
Drain cut-off cur	rent	I _{DSS}	V _{DS} = 500 V, V _{GS} = 0 V	_	_	300	μΑ
Drain-source bro	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	500	_	_	V
Gate threshold v	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source Of	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 13 A	-	0.15	0.20	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 13 A	10	21	_	S
Input capacitanc	е	C _{iss}		-	3700	_	
Reverse transfer	capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	-	400	_	pF
Output capacitar	nce	Coss			920	_	
Switching time Fall	Rise time	t _r	$V_{GS} \stackrel{10V}{\underset{0V}{\longrightarrow}} I_{D} = 13A$ $V_{OUT} \stackrel{R_{L}}{\underset{10}{\longrightarrow}} = 16\Omega$ $V_{DD} = 200V$	_	185	_	- ns
	Turn-on time	t _{on}		_	240	_	
	Fall time	t _f		_	250	_	
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{\rm W} = 10 \mu \rm s$	_	590	_	
Total gate charg plus gate-drain)		l Qg		_	150	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 25 \text{ A}$		70	_	nC
Gate-drain ("miller") charge		Q_{gd}			80		

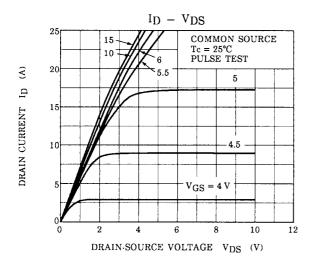
Source-Drain Ratings and Characteristics (Ta = 25°C)

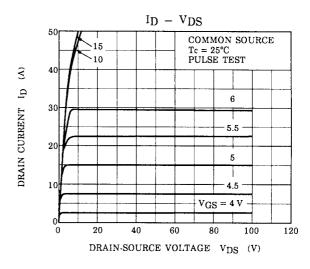
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	25	Α
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	100	Α
Forward voltage (diode)	V_{DSF}	I _{DR} = 25 A, V _{GS} = 0 V	_	_	-1.6	V
Reverse recovery time	t _{rr}	I _{DR} = 25 A, V _{GS} = 0 V	1	780	-	ns
Reverse recovered charge	Q_{rr}	dI _{DR} / dt = 100 A / μs	_	9.8	_	μC

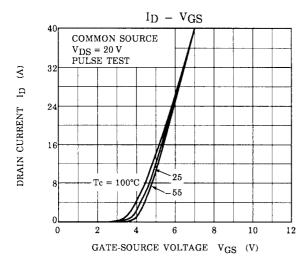
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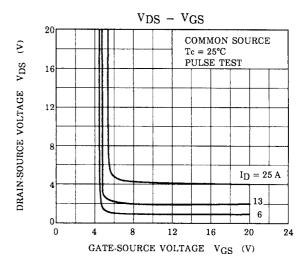


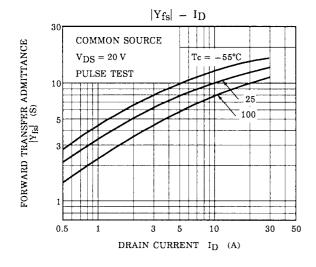
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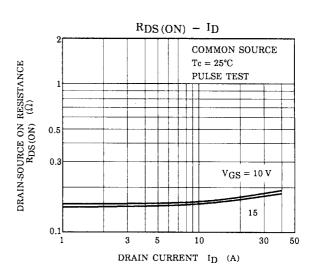




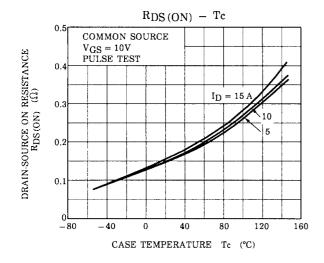


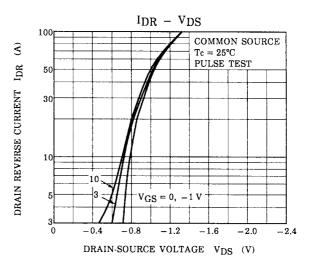


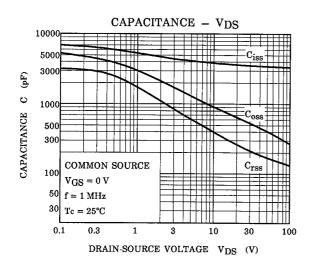


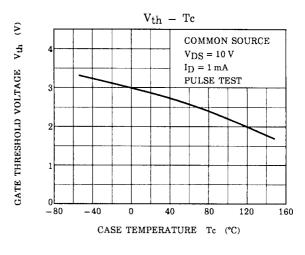


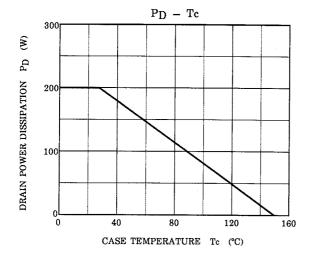
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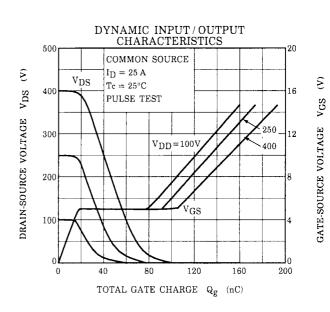




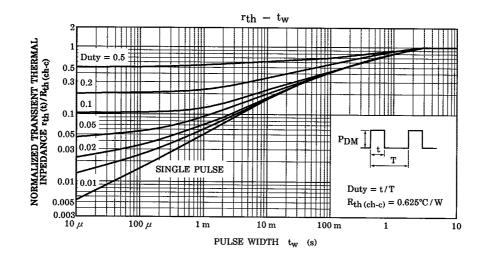


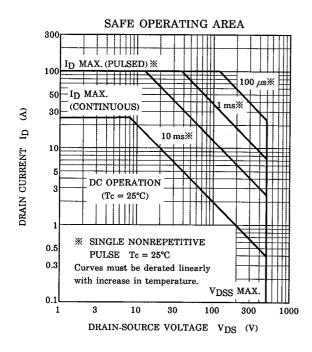






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